HUAWEI DEVICE CO., LTD.

RECIPIENT

SPECIFICATIONS

Product No. : X1G004131000500

MODEL : TG-5006CJ-11V
19.2MHz

SPEC. No. : A13-088-0B

DATE: Jun. 10. 2013

SEIKO EPSON CORPORATION

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SPECIFICATIONS

1. Application

This document is applicable to the temperature compensated crystal oscillator (TCXO) that is delivered to **HUAWEI DEVICE CO., LTD.** from SEIKO EPSON Corp.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by SEIKO EPSON Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.
Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use.
We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

2. Model

The product No. of this crystal oscillator unit is **X1G0041310005**.
The model is **TG-5006CJ-11V** (VCTCXO)

3. Packing

It is subject to the packing standard of SEIKO EPSON Corp.

4. Amendment and abolishment

Amendment and/or abolishment of this specification are subject to the agreement of both parties.

5. Contents

Item No.	Item	Page
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6. MSL

MSL level : 2a

[1] Characteristics

- Lead Free Reflowable and ultra small SMD(2.0 × 1.6 × 0.75 mm).
- Using the heat-resisting type AT cut quartz crystal allows almost the same temperature soldering as universal SMD IC.
- Operating supply voltage: 2.8V.

[2] Absolute maximum ratings

Parameter	Symbol	Value	Unit	Note
Supply voltage	V_{CC}-GND	-0.3 to 4.5	V	
Maximum input voltage	V_{IN}	-0.3 to V_{CC} +0.3	V	V_C terminal
Storage temperature range	$T_{_STG}$	-40 to +90	°C	

[3] Operating range

Parameter		Symbol	Value			Unit	Note
			Min.	Typ.	Max.		
Power voltage		V_{CC}	2.60	2.80	3.00	V	V_{CC} = 2.8V ± 0.2 V
Power voltage		GND	0.0	0.0	0.0	V	
Frequency control voltage		V_C	0.1	0.9	1.7		V_C = 0.9V ± 0.8 V
Operating temperature range		T_use	-40	+25	+85	°C	
Output load		Load_R	4.5	5	5.5	kΩ	
		Load_C	36	40	44	pF	
	DC-cut capacitor	C_C	0.01			μF	

DC-cut capacitor is not included in our VCTCXO. Please insert DC-cut capacitor (0.01uF Min.) in output line.

[4] Frequency characteristics

1) Output frequency 19.200000 MHz

2) Frequency characteristics

(Condition : V_{CC} = 2.8V, V_C = 0.9V, Load 5kΩ // 40pF(DC cut), T_use =+25°C)

Parameter	Symbol	Value	Unit	Note
Frequency tolerance	f_tol(osc)	± 1.0 Max.	× 10^{-6}	T_use = +25 °C ± 2 °C Before Reflow
	f_tol	± 2.5 Max. *1	× 10^{-6}	T_use = +25 °C ± 2 °C Reflow cycle : 2time *2
Frequency / Temperature characteristics	fo-Tc	± 2.0 Max.	× 10^{-6}	T_use = -40 °C to +85 °C (Based on frequency at +25 °C)
Frequency / Temperature change	fo-Tc/*C	± 0.15 Max.	× 10^{-6}/°C	T_use =-30 °C to +85 °C
		± 0.25 Max.		T_use = -40 °C to -30 °C
Frequency / Load coefficient	fo-Load	± 0.2 Max.	× 10^{-6}	Load : 5 kΩ // 40 pF ± 10%each
Frequency / Voltage coefficient	fo-V_{CC}	± 0.2 Max.	× 10^{-6}	V_{CC} = 2.8V ± 0.2 V
Frequency aging	f_age	± 0.7 Max.	× 10^{-6}	first year T_use =+25 °C
		± 8.0 Max.	× 10^{-6}	10 years T_use =+25 °C

*1 Include initial frequency tolerance and frequency deviation after reflow cycles.

*2 Measurement of frequency deviation is made 24h after reflow soldering.

[5] Frequency adjustment characteristics

(Condition : V_{CC} = 2.8V, V_C = 0.9V, Load 5kΩ // 40pF(DC cut), T_use =+25°C)

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Frequency control range	tosc	± 5 × 10^{-6}	-	± 12 × 10^{-6}	-	V_C = 0.9 V ± 0.8 V
Input impedance (V_C terminal)	Rin	500k	-	-	Ω	V_C – GND (DC level)
Transfer function	-	Positive polarity			-	

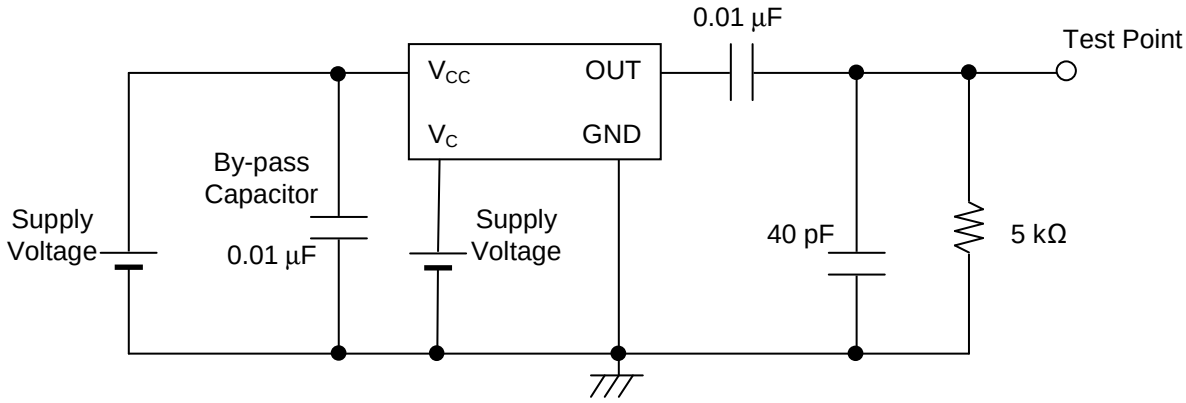
[6] Electrical characteristics

(Condition : V_{CC} = 2.8V, V_C = 0.9V, Load 5kΩ // 40pF(DC cut), T_use =+25°C)

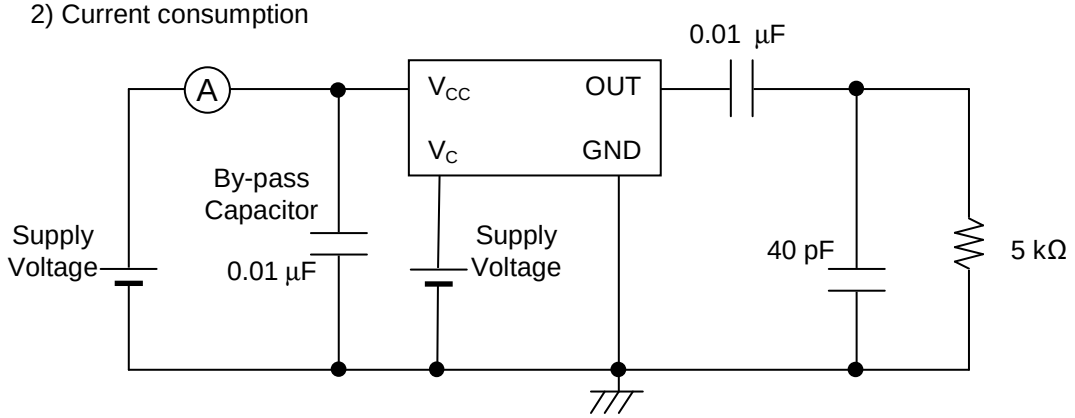
Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Current consumption	I_{CC}	-	1.8	3.0	mA	
Output level	V_{PP}	0.8	-	-	V	Peak to peak voltage
Symmetry	SYM	45	-	55	%	GND Level
Harmonics	-	-	-	-8	dBc	
Start up time	f-time	-	-	1.5	msec	Until freqency has been reached within ±1 ppm of final freqency.
		-	-	1.5		Until output signal has been reached min90% of final amp.
SSB Phase noise	L(f)	-	-90	-78	dBc /Hz	Offset:10 Hz
		-	-116	-110		Offset:100 Hz
		-	-135	-130		Offset:1 kHz
		-	-146	-144		Offset:10 kHz
		-	-150	-148		Offset:100 kHz
		-	-151	-148		Offset:1 MHz

[7] Test circuit

1) Output Load : 5 kΩ//40 pF



2) Current consumption



3) Conditions

1. Oscilloscope: Impedance Min. 1 MΩ
   Input capacitance Max. 10 pF
   Band width Min. 300 MHz
   Impossible to measure both frequency and wave form at the same time.(In case of using oscilloscope's amplifier output, possible to measure both at the same time.)
2. CL includes probe capacitance.
3. A capacitor (By-pass:0.01 μF) is placed between V_{CC} and GND,and closely to TCXO.
4. Use the current meter whose internal impedance value is small.
5. Power Supply
   Impedance of power supply should be as lowest as possible.
6. GND should apply one point earth.

[8] Environmental and mechanical characteristics

(The company evaluation condition. we evaluate it by the following examination item and examination condition.)

No.	Item	Value *1 Freq. Tolerance [1×10^{-6}] *2 Electrical characteristics	Test method
1	High temp. storage *3	± 2.0	+85 °C × 1000 h
2	Low temp. storage *3	± 2.0	-40 ℃ × 1000 h
3	Temp. cycle *3	± 2.0	-40 ℃ to +85 ℃ (30 min × 100 cycle/each)
4	Resistance to Soldering heat (Reflow characteristics)	± 1.0	Reflow furnace with the condition 2 times
5	Drop	± 2.0	Free drop from 750 mm height on a hard wooden board for 3 times.
6	Solderability	Terminals must be 95 % covered with fresh solder	Dip termination into solder bath at +235 ℃ for 5 s (Using Rosin Flux)

Notes

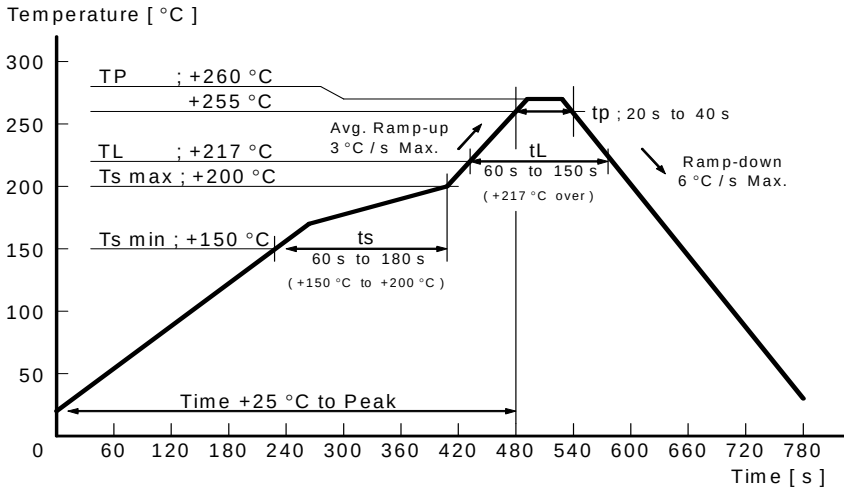
1.*1 each test is independent.

2.*2 measuring 2 h to 24 h later leaving in room temperature after each test.

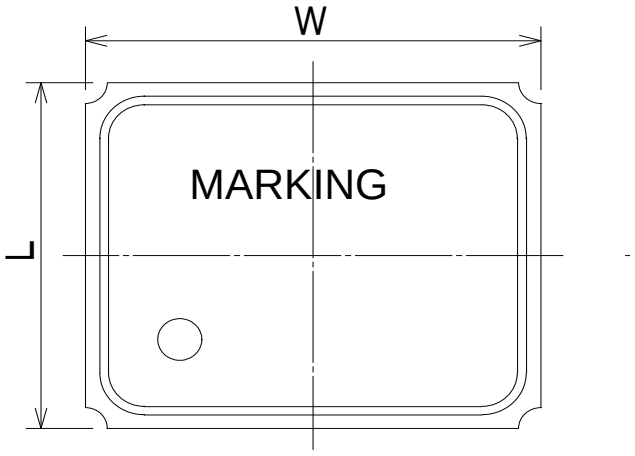
3.*3 Pre conditionings

1. reflow 2 times
2. Initial value shall be after 24 h at room temperature.

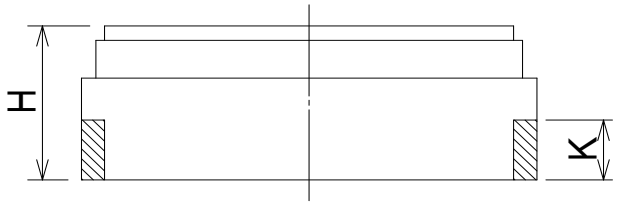
Reflow condition (follow to IPC / JEDEC J-STD-020C)



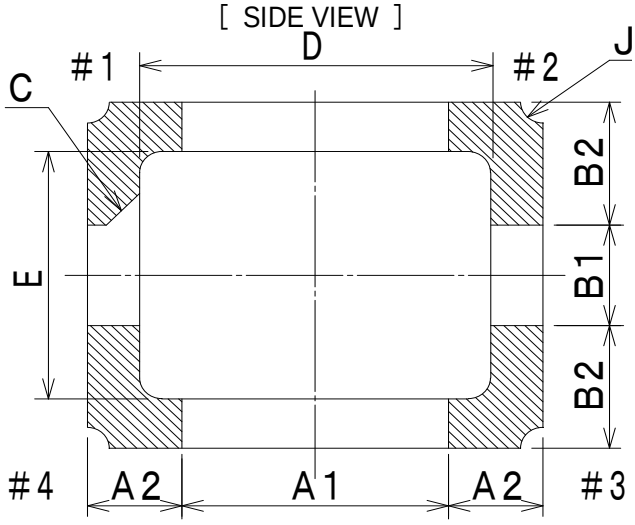
[9] Dimensions And Marking Layout



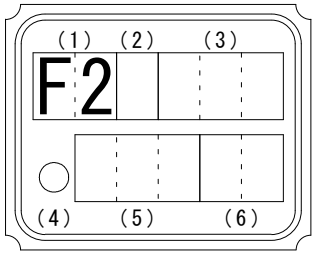
[TOP VIEW]



[SIDE VIEW]



[BOTTOM VIEW]



Marking

(1) TCXO Model ID (F2)
(2) TCXO Product place
(3) TCXO Lot No.
(4) 1Pin Mark
(5) XTAL Lot No.
(6) XTAL Model ID

Connection

Pin No.	Terminal
# 1	V_C
# 2	GND
# 3	OUT
# 4	V_{CC}

Material

Ceramics(base)
Au coated nickel(terminal)
Fe-Ni-Co(lid)

Unit : mm

DIM.	MIN.	TYP.	MAX.
W	1.85	2.00	2.15
L	1.45	1.60	1.75
H	0.66	0.73	0.80
J	---	R0.10	---
K	---	0.27	---

DIM.	TYP.
A1	1.20
A2	0.4
B1	0.4
B2	0.6
C	C0.15
D	1.58
E	1.18

Co-planarity : 0.05mm

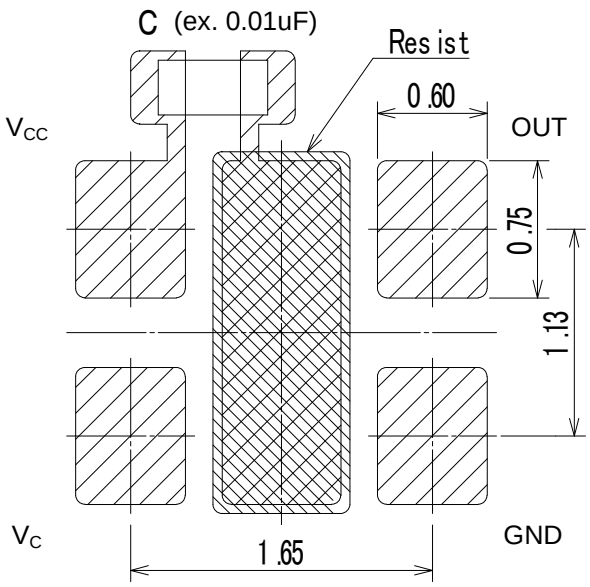
[10] Recommendable patterning

For actual design work, please consider optimum condition together with mounting density, reliability of soldering and mount ability etc.

Do not design any patterns except GND on the shaded area.

Soldering position

Unit: mm



[11] Handling precautions

Prior to using this product, please carefully read the section entitled “Precautions” on our Web site (http://www5.epsondevice.com/en/quartz/tech/precaution/) for instructions on how to handle and use the product properly to ensure optimal performance of the product in your equipment. Before using the product under any conditions other than those specified therein, please consult with us to verify and confirm that the performance of the product will not be negatively affected by use under such conditions.

In addition to the foregoing precautions, in order to avoid the deteriorating performance of the product, we strongly recommend that you DO NOT use the product under ANY of the following conditions:

(1) Mounting the product on a board using water-soluble solder flux and using the product without removing the residue of the flux completely from the board. The residue of such flux that is soluble in water or water-soluble cleaning agent, especially the residues which contains active halogens, will negatively affect the performance and reliability of the product.
(2) Using the product in any manner that will result in any shock or impact to the product.
(3) Using the product in places where the product is exposed to water, chemicals, organic solvent, sunlight, dust, corrosive gasses, or other materials.
(4) Using the product in places where the product is exposed to static electricity or electromagnetic waves.
(5) Applying ultrasonic cleaning without advance verification and confirmation that the product will not be affected by such a cleaning process, because it may damage the crystal, IC and/or metal line of the product.
(6) Touching the IC surface with tweezers or other hard materials directly.
(7) Using the product under any other conditions that may negatively affect the performance and/or reliability of the product.
(8) Using the product with power line ripple exceeding 200 mV(p-p) level.

Should any customer use the product in any manner contrary to the precautions and/or advice herein, such use shall be done at the customer’s own risk.

TAPING SPECIFICATION (STD)

Ⅰ. Application

This standard will apply to 2.0×1.6 SMD package.

Spec：CJ package

Ⅱ. Contents

Item No.	Item	Page
〔1〕	Taping specification	1 to 2
〔2〕	Inner carton	3
〔3〕	Shipping carton	
〔4〕	Marking	4
〔5〕	Quantity	
〔6〕	Storage environment	
〔7〕	Handling	

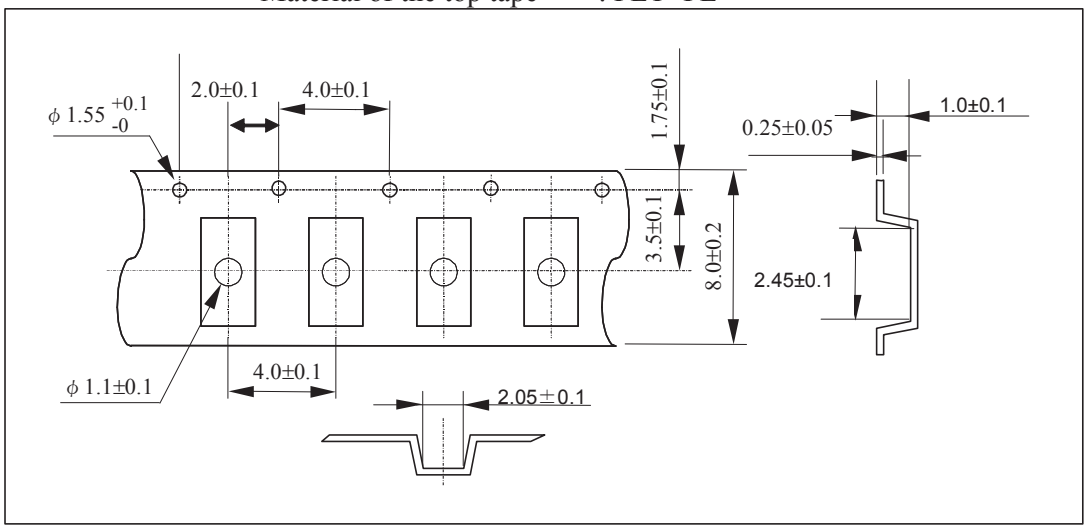
〔1〕 Taping specification

Subject to EIA-481& IEC-60286

(1) Tape dimensions

Material of the carrier tape : PS （BLACK /Electric conduction）

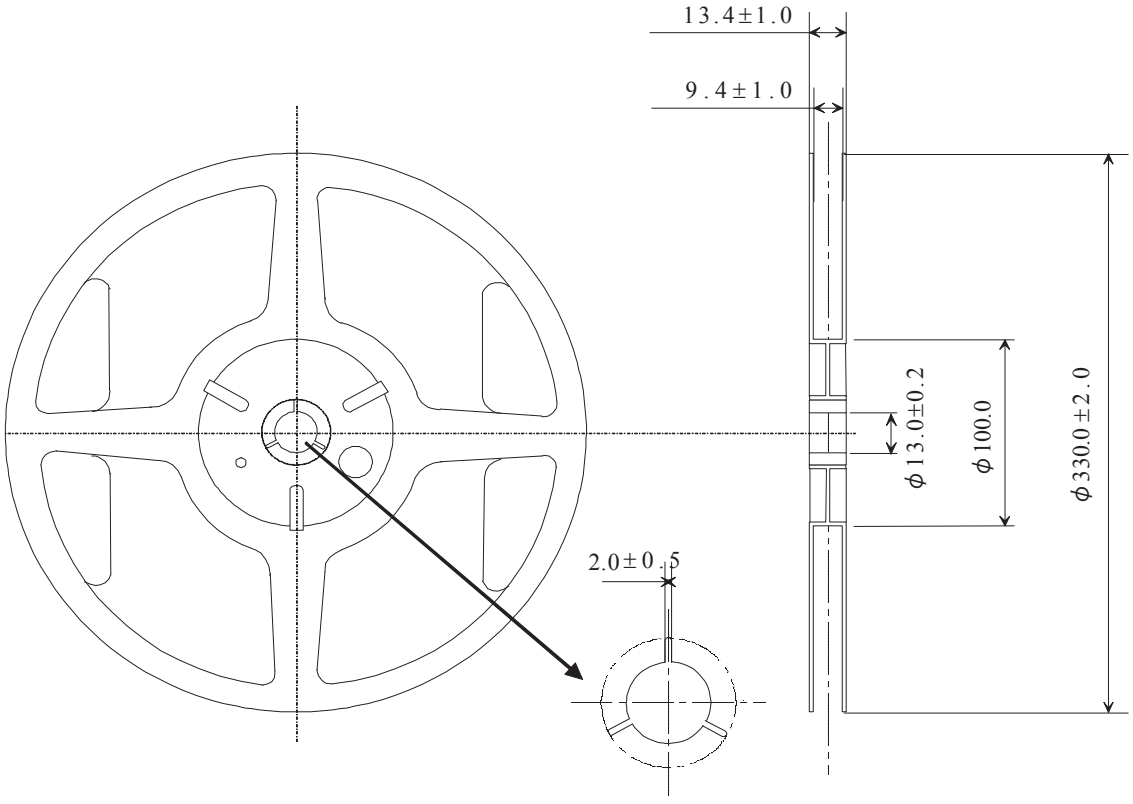
Material of the top tape : PET+PE



Unit : mm

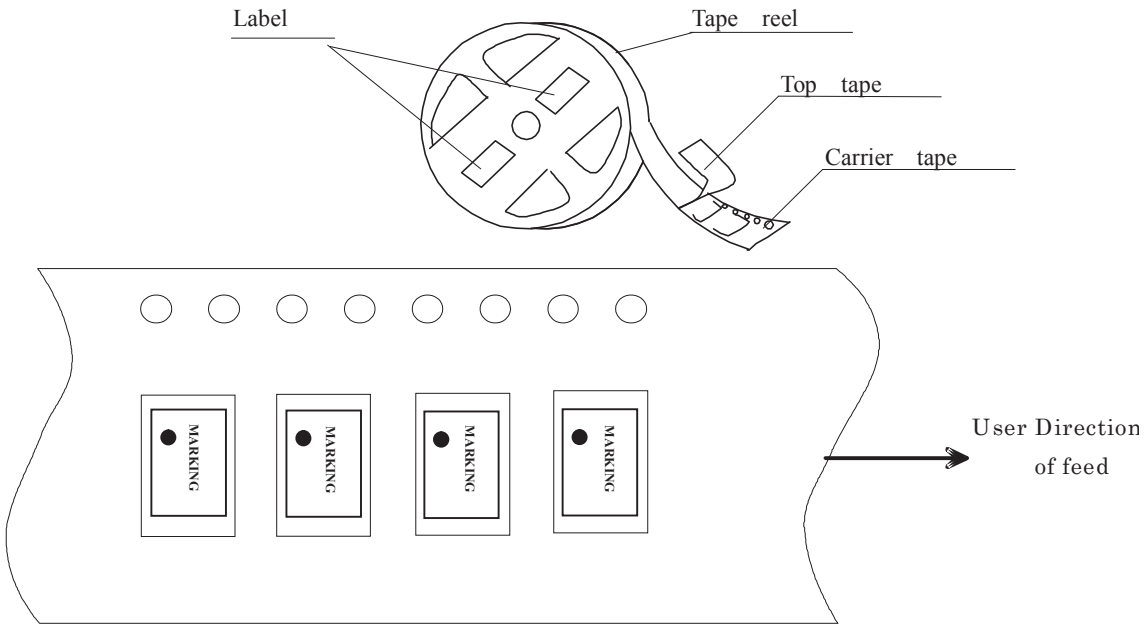
(2) Reel dimensions

Material of the reel : Conductive polystyrene（BLACK /Electric conduction）

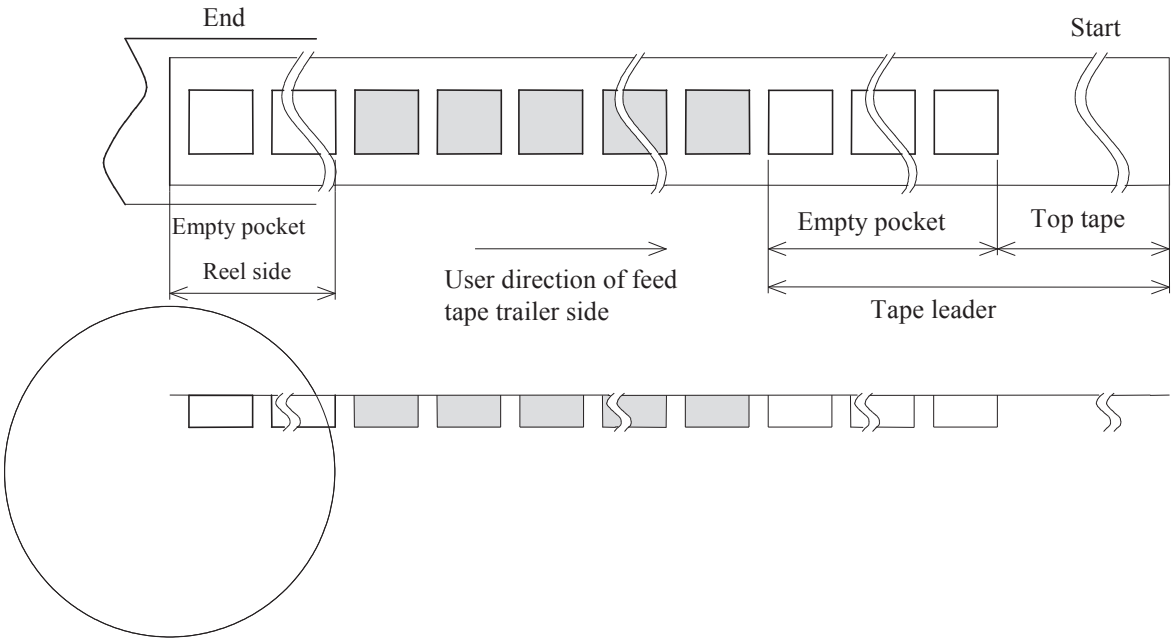


(3) Packing

①Tape & reel



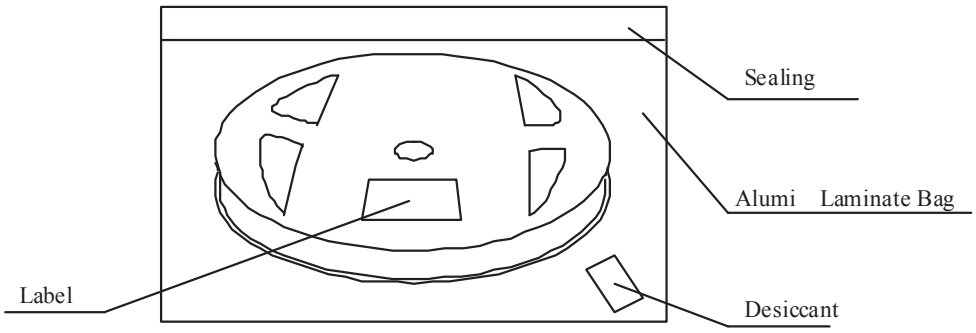
②Start & end point



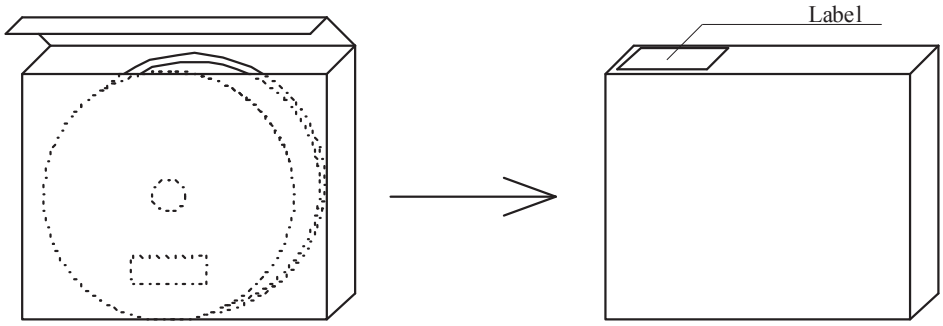
Item		Empty space	Note
Tape leader	Top tape	Min. 200 mm	Top tape shall be fixed using tape and/or polyethylene seal.
	Carrier tape	Min. 150 mm	
Tape trailer	Top tape	Min. 0 mm	Tape end point shall be fixed using tape or hooked in core area.
	Carrier tape	Min. 150 mm	

〔2〕 Inner carton

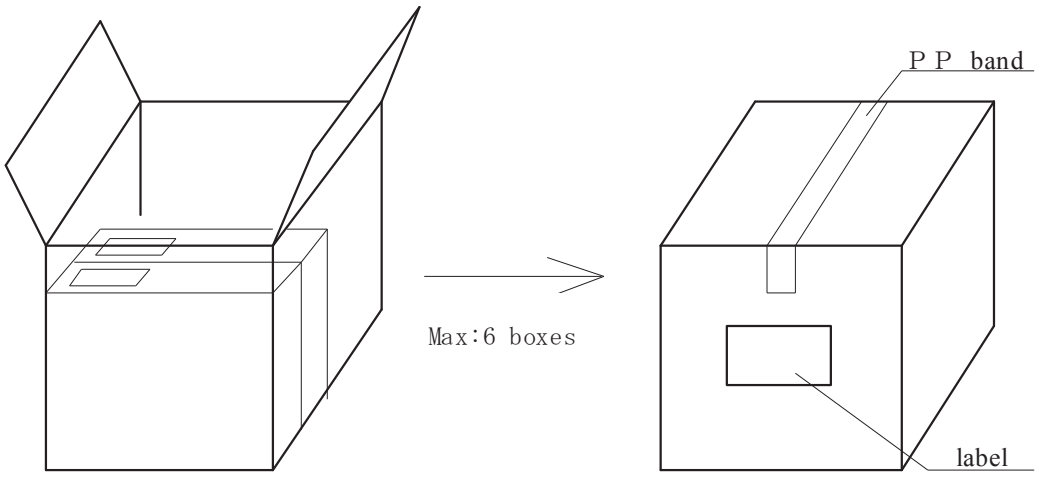
a) Packing to Alumi Laminate bag



b) Packing to inner carton



〔3〕 Shipping carton



〔4〕 Marking

(1) Reel marking

・Reel marking shall consist of :

1) Parts name
2) Quantity
3) Manufacturing date or symbol
4) Manufacturer or symbol
5) Others (if necessary)
6) Pb-Free Marking : LF

Example of label-1

CRYSTAL OSCILLATOR	
P/N: 452002	P/O: 12345678901234567890
TG-50XXCJ-XXX XXMHz	MSL Level-2 LF
LOT NO: 0000000000	QUANTITY: 12,000
WEEK CODE:/ XXXXXX	X1G000000000 ** YYYY.MM.DD
EPSON TOYOCOM	MADE IN: JAPAN

(2) Inner carton and Alumi Laminate bag marking

・Same as reel marking.

(3) Shipping carton marking

・Shipping carton marking shall consist of

1) Parts name
2) Quantity

〔5〕 Quantity

・Max. 12,000 pcs./reel
・Min. 500 pcs./reel

note) The above quantity is our standard packing size.
In case of an odd sum as per the purchased quantity, the packing quantity might be below our standard minimum packing size.

〔6〕 Storage environment

(1) To storage the reel at 15 °C to 35 °C, 25 %RH to 85 %RH of humidity.
(2) To open the packing just before using.
(3) Not to expose the sun.
(4) Not to storage with some erosive chemicals.
(5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

〔7〕 Handling

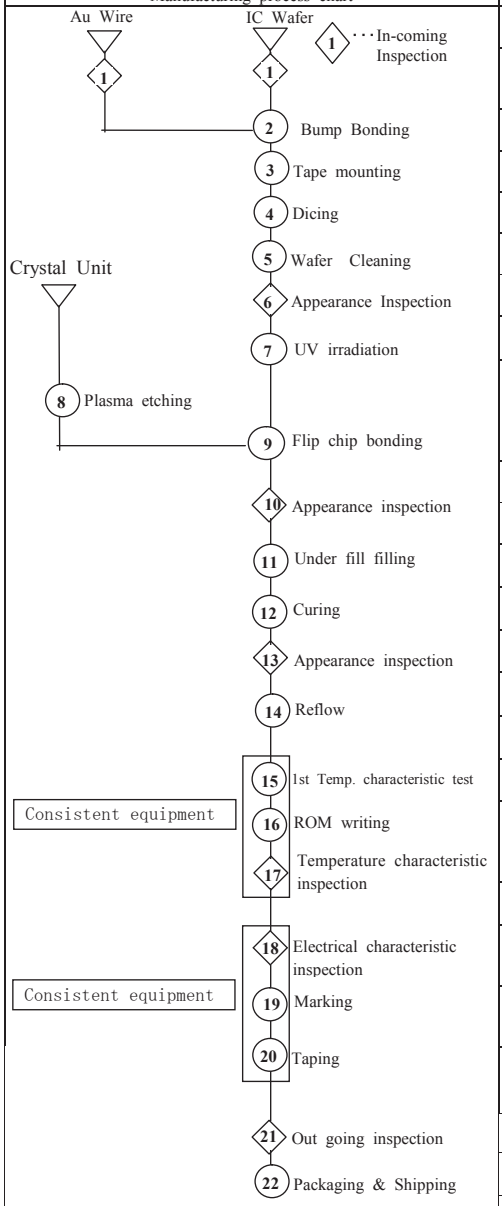
・To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

'13.02.27
SEIKO EPSON CORP.
Timing Device Business Unit

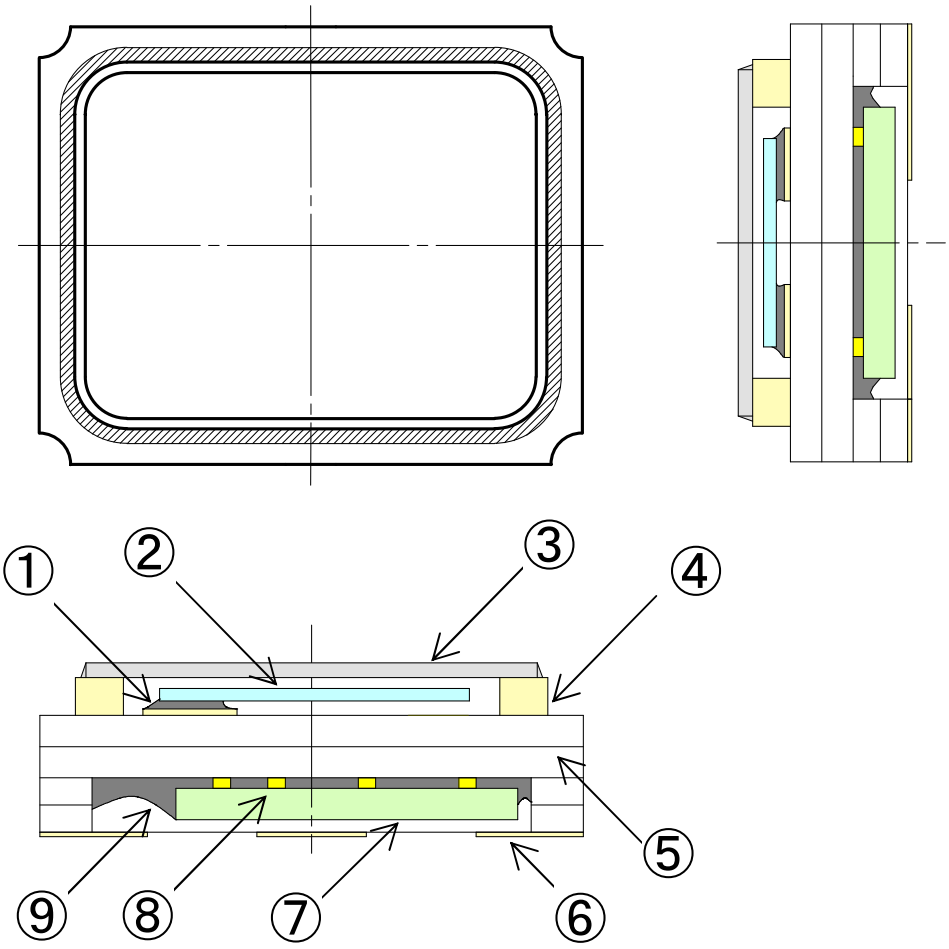
Approved	Checked	Prepared
H.koike		H.suzuki

No. TG5006CJ - 00 – AAE - 1 CRYSTAL OSCILLATOR : TG-5006CJ



Manufacturing process chart	No.	Section In Charge	Standards	Inspection, Control Item	Instruments	Inspection Methods	Record
Au Wire / IC Wafer	1	ETMY Sub contructor	Purchase specification Delivery card	Appearance	Visual inspection	Every lot	Data sheet
2 Bump Bonding	2	ETMY Sub contructor	Specification (Work standard)	Heater temperature Bump dimension Shear strength	Thermometer Microscope Bond tester	Daily Sampling Sampling	Daily check sheet Data sheet Data sheet
3 Tape mounting	3	ETMY Sub contructor	Specification (Work standard)	Cutting condition Appearance	Visual inspection	Daily	Daily check sheet
4 Dicing	4	ETMY Sub contructor	Specification (Work standard)	Abrasion loss of Blade	Built-in gauge	Every batch	Tool change check sheet
5 Wafer Cleaning	5	ETMY Sub contructor	Specification (Work standard)	Water resistance	Built-in meter	Daily	Daily check sheet
6 Appearance Inspection	6	ETMY Sub contructor	Specification (Work standard)	Dicing condition	Microscope	Sampling	Data sheet
7 UV irradiation	7	ETMY Sub contructor	Specification (Work standard)	UV condition	UV intensity meter	Daily	Daily check sheet
8 Plasma etching	8	ETMY Sub contructor	Specification (Work standard)	Flow rate of O2 and Ar	Built-in meter	Daily	Daily check sheet
9 Flip chip bonding	9	ETMY Sub contructor	Specification (Work standard)	Number of US tool shots Number of ejector needle shot. Heater temperature Bump dimension Shear strength	Built-in counter Built-in counter Thermometer Microscope Bond tester	100% 100% Daily Sampling Sampling	Tool change check sheet Daily check sheet Data sheet Data sheet
10 Appearance inspection	10	ETMY Sub contructor	Specification (Work standard)	Flipchip bonding Condition	Microscope	Sampling	Data sheet
11 Under fill filling	11	ETMY Sub contructor	Specification (Work standard)	Chip coat storage temp. Pot lifetime	Thermometer Built-in timer	Daily 100%	Daily check sheet Tool change check sheet
12 Curing	12	ETMY Sub contructor	Specification (Work standard)	Curing time Oven temperature	Timer Thermometer	Every batch Daily	Data sheet Daily check sheet
13 Appearance inspection	13	ETMY Sub contructor	Specification (Work standard)	Appearance (FC & Under fill condition)	Microscope	100% Inspection	Data sheet
14 Reflow	14	ETMY Sub contructor	Specification (Work standard)	Reflow profile	Thermometer	Daily	Daily check sheet
	15	ETMY Sub contructor	Specification (Work standard)	Stage temperature	Thermometer	Daily	Daily check sheet
	16	ETMY Sub contructor	Specification (Work standard)	Stage temperature	Thermometer	Daily	Daily check sheet
15 1st Temp. characteristic test Consistent equipment 16 ROM writing 17 Temperature characteristic inspection	17	ETMY Sub contructor	Specification (Work standard)	Stage temperature Temperature characteristic	Thermometer Frequency counter	Daily 100% Inspection	Daily check sheet Data sheet
	18	ETMY Sub contructor	Specification (Work standard)	Frequency, Output-level Current drain, Frequency control range Master confirmation	Multi-meter Freq. counter Oscilloscope	100% Inspection	Data sheet
	19	ETMY Sub contructor	Specification (Work standard)	Appearance Marking	CCD camera	100% Inspection	Data sheet
18 Electrical characteristic inspection	20	ETMY Sub contructor	Specification (Work standard)	Peeling off strength Direction	Peel back tester Visual inspection	Daily Sampling Delivery lot	Daily check sheet Data sheet
Consistent equipment 19 Marking 20 Taping	21	ETMY Sub contructor	Specification (Work standard)	Frequency, Current drain, Appearance, Dimension	Freq. counter,Multi-meter, Visual inspection Calipers	Sampling	Data sheet
21 Out going inspection	22	Production Control Department (ETMY Sub contructor & ETMY & Ina Plant)	Specification (Work standard)	Quantity	Visual inspection	Sampling Delivery lot	Data sheet Delivery record
22 Packaging & Shipping							

Structure diagram. TG-5006CJ



LIST		
Name of part		Specification
1	XTAL adhesives	Ag paste
2	XTAL chip	AT cut
3	Lid	Fe – Ni – Co
4	Seam ring	Kovar – Ni – Au
5	Base	Ceramic PKG
6	Terminal	Au coated , Ni
7	IC	CMOS
8	FC bump	Au
9	UF	Potting resin
10		

OUT-13-0213_A		
MGR.	CHK.	ENG.
Y.Shishido.		H.Hirano.

RELIABILITY TEST DATA

Product Name : TG-50xxCJ series (~40MHz)

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . **OUT-11-0087**

No.	ITEM	TEST CONDITIONS	VALUE *1		TEST Qty [n]	FAIL Qty [n]
			Δ f / f *2 [1 × 10^{-6}]	Electrical characteristics		
1	High temperature storage	+85 °C × 1 000 h	*3 ± 2.0	Satisfy output level after test	22	0
2	Low temperature storage	-40 °C × 1 000 h	*3 ± 2.0		22	0
3	High Temperature with Humidity	+85 ± 2 °C × 85 ± 5 %RH × 1 000 h	*3 ± 2.0		22	0
4	Temperature cycle	-40 °C ⇔ +85 °C 30 min at each temp. 1000 cycles	*3 ± 2.0		22	0
5	Resistance to soldering heat	Convection reflow soldering furnace (3 times)	± 1.0		22	0
6	Drop	150g dummy jig (Epson Toyocom Standard) drop from 1500 mm height on the concrete 6 directions 3 times.	± 2.0		22	0
7	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s^2 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h (2 h × 3 directions)	± 2.0		22	0
8	ESD (MM)	200pF 0Ω 200V , Discharge 3 pulses	± 1.0		22	0
9	ESD (HBM)	100pF 1.5kΩ 2000V , Discharge 3 pulses	± 1.0		22	0
10	Solderability	Dip termination into solder bath at +235 °C ± 5 °C for 5 s (Using Rosin Flux)	Termination must be covered with fresh solder more than 95 % of dip area.		11	0

Notes

1. *1 Each test done independently.
2. *2 Measuring 2 h to 24 h later leaving in room temperature after each test.
3. *3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment
   Pre-treatment : Bake (+125 ℃ × 24 h) →Moisture soak (+85 ℃ × 60 % × 168 h) →reflow (3 times)

Qualification Data

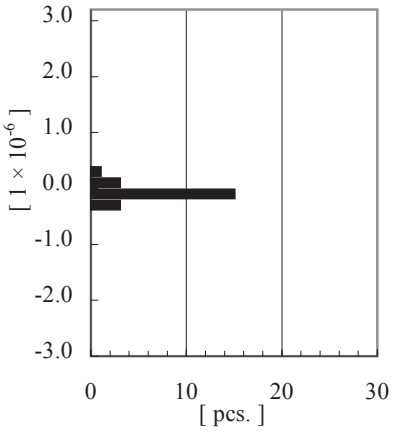
EPSON
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Product Name : TG-50xxCJ series (~40MHz)

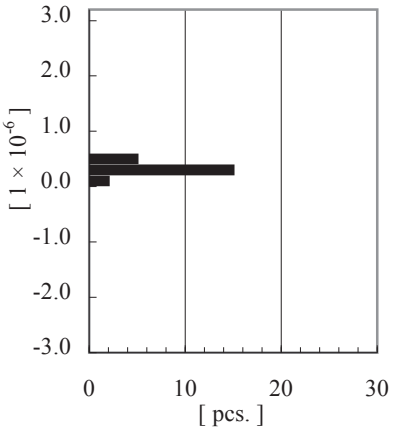
df / f

OUT-11-0087

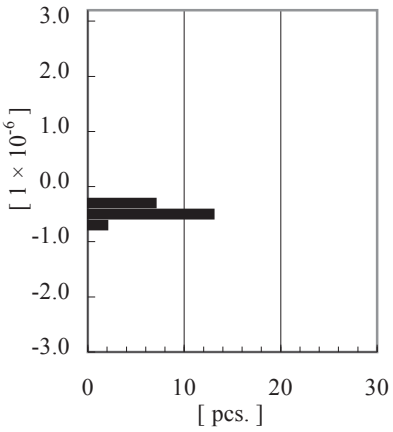
1. High temp. storage
+85 °C × 1 000 h



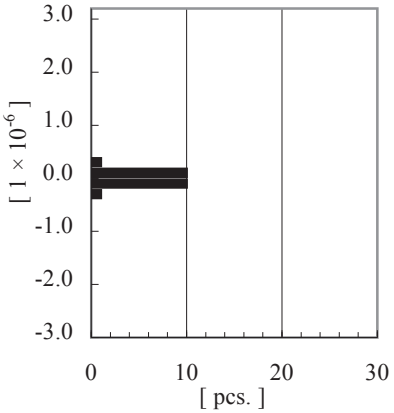
2. Low temp. storage
-40 °C × 1 000 h



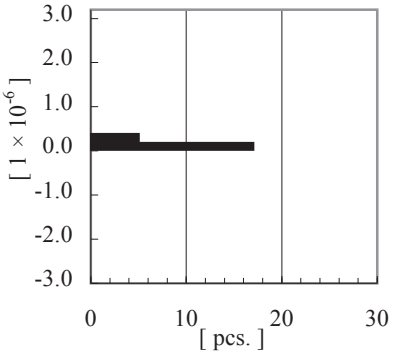
3. Temp. humidity storage
+85 °C × 85 %RH × 1 000 h



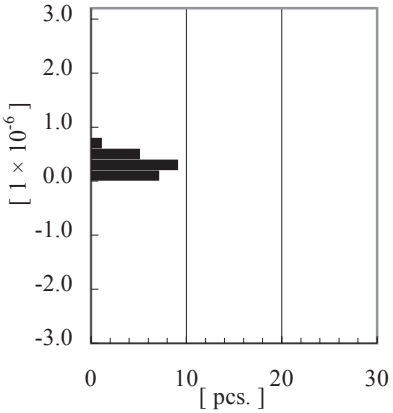
4. Temp. cycle
-40 °C ⇔ +85 °C
1000 cycles



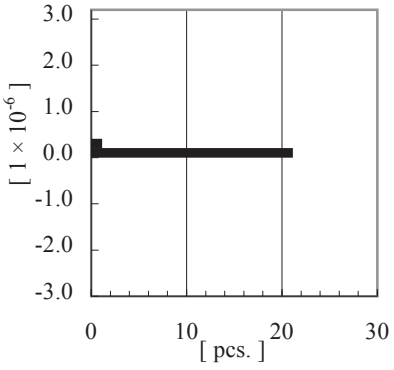
5. Resistance to soldering heat
For convention reflow
soldering furnace (3 times)



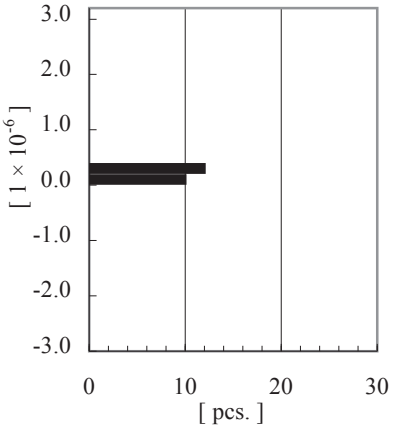
6. Drop
1500 mm × 6 times



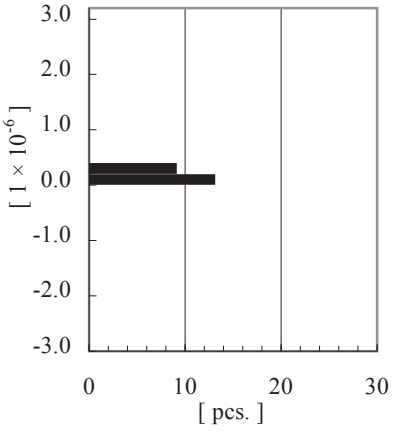
7. Vibration
10 Hz to 55 Hz amplitude 0.75 mm
55 Hz to 500 Hz acceleration 98 m/s^2
15 min / cycle
6 h (2 h × 3 directions)



8. ESD (MM)
200pF 0Ω 200V



9. ESD (HBM)
100pF 1.5kΩ 2000V



Qualification Data

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ST13-102
Jun., 10, 2013

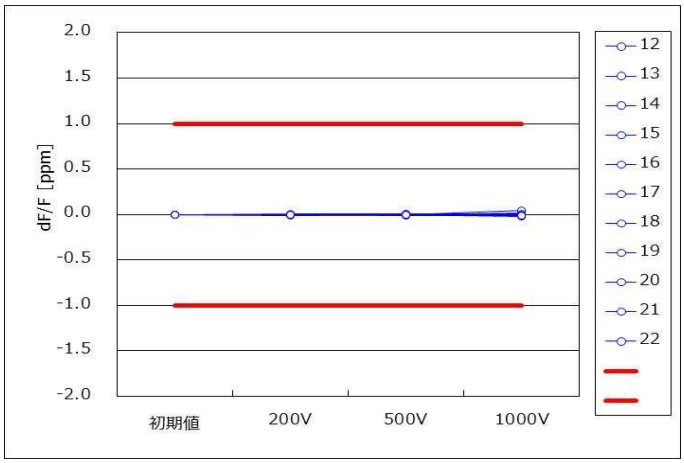
Electro Static Discharge

SEIKO EPSON CORPORATION
TD･CS Quality Assurance Dept.

Product Name :TG-5006xx series
LEVEL :H1C

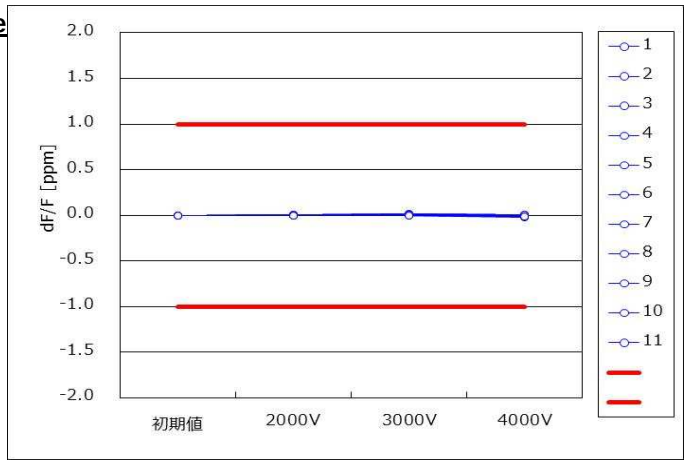
No.	Item	Test term	Test Quy [n]	Result
1	Machine Model	EIAJ ED-4701-1 C111 200 pF, 0 Ω, 1 time ElectroStatic Discharge:±200V	5	OK
2	Human Body Model	EIAJ ED-4701-1 C111A 100 pF,1.5 KΩ, 3 time ElectroStatic Discharge:±2000V	5	OK

Machine Model



No problem to 200V

Human Body Mode



No problem to 2000V